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Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/790,709	ARAI, SATOSHI	
Examiner	Art Unit	_
Tuan H Nauven	2618	

	SEAR	CHED	
Class	Subclass	Date	Examiner
455	78,88	12/7/2006	T.N
455	300,550.1	12/7/2006	T.N
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH		<u> </u>
	DATE	EXMR
All searches are on EAST data base.	12/7/2006	T.N
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